

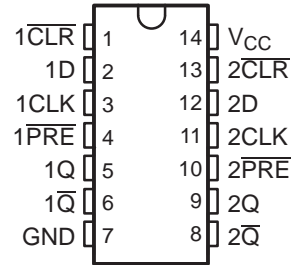
FEATURES

- **Controlled Baseline**
 - One Assembly/Test Site, One Fabrication Site
- **Extended Temperature Performance of –40°C to 125°C and –55°C to 125°C**
- **Enhanced Diminishing Manufacturing Sources (DMS) Support**
- **Enhanced Product-Change Notification**
- **Qualification Pedigree ⁽¹⁾**
- **Operates From 2 V to 3.6 V**

(1) Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

- **Inputs Accept Voltages to 5.5 V**
- **Max t_{pd} of 5.2 ns at 3.3 V**
- **Typical V_{OLP} (Output Ground Bounce) <0.8 V at $V_{CC} = 3.3 V, T_A = 25^\circ C$**
- **Typical V_{OHV} (Output V_{OH} Undershoot) >2 V at $V_{CC} = 3.3 V, T_A = 25^\circ C$**

D OR PW PACKAGE
(TOP VIEW)



DESCRIPTION/ORDERING INFORMATION

The SN74LVC74A dual positive-edge-triggered D-type flip-flop is designed for 2.7-V to 3.6-V V_{CC} operation.

A low level at the preset (\overline{PRE}) or clear (\overline{CLR}) inputs sets or resets the outputs, regardless of the levels of the other inputs. When \overline{PRE} and \overline{CLR} are inactive (high), data at the data (D) input meeting the setup time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold-time interval, data at the D input can be changed without affecting the levels at the outputs.

Inputs can be driven from either 3.3 V or 5 V devices. This feature allows the use of this device as a translator in a mixed 3.3 V/5 V system environment.

ORDERING INFORMATION⁽¹⁾

| T_A | PACKAGE ⁽²⁾ | | ORDERABLE PART NUMBER | TOP-SIDE MARKING |
|----------------|------------------------|--------------|-----------------------|------------------|
| –40°C to 125°C | SOIC – D | Reel of 2500 | SN74LVC74AQDREP | LVC74AE |
| | TSSOP – PW | Reel of 2000 | SN74LVC74AQPWREP | LVC74AE |
| –55°C to 125°C | SOIC – D | Reel of 2500 | SN74LVC74AMDREP | LVC74AM |
| | TSSOP – PW | Reel of 2000 | SN74LVC74AMPWREP | LVC74AM |

- (1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.
 (2) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.



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SN74LVC74A-EP DUAL POSITIVE EDGE TRIGGERED D-TYPE FLIP-FLOP WITH CLEAR AND PRESET

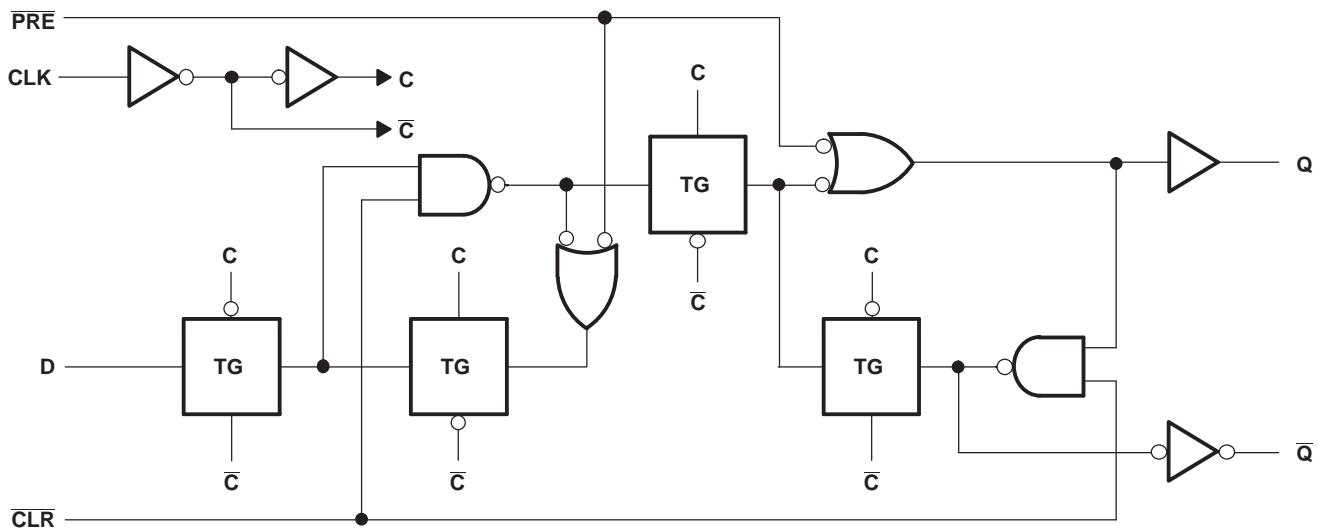
SCAS751C—DECEMBER 2003—REVISED SEPTEMBER 2007

FUNCTION TABLE

| INPUTS | | | | OUTPUTS | |
|--------|-------------------------|-----|---|------------------|-------------------------|
| PRE | $\overline{\text{CLR}}$ | CLK | D | Q | $\overline{\text{Q}}$ |
| L | H | X | X | H | L |
| H | L | X | X | L | H |
| L | L | X | X | H ⁽¹⁾ | H ⁽¹⁾ |
| H | H | ↑ | H | H | L |
| H | H | ↑ | L | L | H |
| H | H | L | X | Q ₀ | $\overline{\text{Q}}_0$ |

(1) This configuration is nonstable; that is, it does not persist when $\overline{\text{PRE}}$ or $\overline{\text{CLR}}$ returns to its inactive (high) level.

LOGIC DIAGRAM, EACH FLIP-FLOP (POSITIVE LOGIC)



Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

| | | MIN | MAX | UNIT | |
|------------------|---|--------------------|-----------------------|------|------|
| V _{CC} | Supply voltage range | –0.5 | 6.5 | V | |
| V _I | Input voltage range ⁽²⁾ | –0.5 | 6.5 | V | |
| V _O | Output voltage range ⁽²⁾⁽³⁾ | –0.5 | V _{CC} + 0.5 | V | |
| I _{IK} | Input clamp current | V _I < 0 | | –50 | mA |
| I _{OK} | Output clamp current | V _O < 0 | | –50 | mA |
| I _O | Continuous output current | | | ±50 | mA |
| | Continuous current through V _{CC} or GND | | | ±100 | mA |
| θ _{JA} | Package thermal impedance ⁽⁴⁾ | D package | | 86 | °C/W |
| | | PW package | | 113 | |
| T _{stg} | Storage temperature range | –65 | 150 | °C | |

- (1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.
- (3) The value of V_{CC} is provided in the recommended operating conditions table.
- (4) The package thermal impedance is calculated in accordance with JESD 51-7.

Recommended Operating Conditions⁽¹⁾

| | | MIN | MAX | UNIT | |
|-----------------|------------------------------------|----------------------------------|-----------------|---------|------|
| V _{CC} | Supply voltage | Operating | | 2 3.6 | V |
| | | Data retention only | | 1.5 | |
| V _{IH} | High-level input voltage | V _{CC} = 2.7 V to 3.6 V | | 2 | V |
| V _{IL} | Low-level input voltage | V _{CC} = 2.7 V to 3.6 V | | 0.8 | V |
| V _I | Input voltage | 0 | 5.5 | | V |
| V _O | Output voltage | 0 | V _{CC} | | V |
| I _{OH} | High-level output current | V _{CC} = 2.7 V | | –12 | mA |
| | | V _{CC} = 3 V | | –24 | |
| I _{OL} | Low-level output current | V _{CC} = 2.7 V | | 12 | mA |
| | | V _{CC} = 3 V | | 24 | |
| Δt/Δv | Input transition rise or fall rate | | | 10 | ns/V |
| T _A | Operating free-air temperature | M suffix | | –55 125 | °C |
| | | Q suffix | | –40 125 | |

- (1) All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. See the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

SN74LVC74A-EP

DUAL POSITIVE EDGE TRIGGERED D-TYPE FLIP-FLOP WITH CLEAR AND PRESET

SCAS751C–DECEMBER 2003–REVISED SEPTEMBER 2007

Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP ⁽¹⁾ | MAX | UNIT |
|------------------|--|-----------------|-----------------------|--------------------|------|------|
| V _{OH} | I _{OH} = -100 μA | 2.7 V to 3.6 V | V _{CC} - 0.2 | | | V |
| | I _{OH} = -12 mA | 2.7 V | 2.2 | | | |
| | | 3 V | 2.4 | | | |
| | I _{OH} = -24 mA | 3 V | 2.2 | | | |
| V _{OL} | I _{OL} = 100 μA | 2.7 V to 3.6 V | | | 0.2 | V |
| | I _{OL} = 12 mA | 2.7 V | | | 0.4 | |
| | I _{OL} = 24 mA | 3 V | | | 0.55 | |
| I _I | V _I = 5.5 V or GND | 3.6 V | | | ±5 | μA |
| I _{CC} | V _I = V _{CC} or GND, I _O = 0 | 3.6 V | | | 10 | μA |
| ΔI _{CC} | One input at V _{CC} - 0.6 V, Other inputs at V _{CC} or GND | 2.7 V to 3.6 V | | | 500 | μA |
| C _i | V _I = V _{CC} or GND | 3.3 V | | 5 | | pF |

(1) All typical values are at V_{CC} = 3.3 V, T_A = 25°C.

Timing Requirements

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

| | | V _{CC} = 2.7 V | | V _{CC} = 3.3 V ± 0.3 V | | UNIT |
|--------------------|----------------------------|-------------------------|-----|---------------------------------|-----|------|
| | | MIN | MAX | MIN | MAX | |
| f _{clock} | Clock frequency | 83 | | 100 | | MHz |
| t _w | Pulse duration | PRE or CLR low | | 3.3 | | ns |
| | | CLK high or low | | 3.3 | | |
| t _{su} | Setup time before CLK↑ | Data | | 3 | | ns |
| | | PRE or CLR inactive | | 2 | | |
| t _h | Hold time, data after CLK↑ | 1 | | 1 | | ns |

Switching Characteristics

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

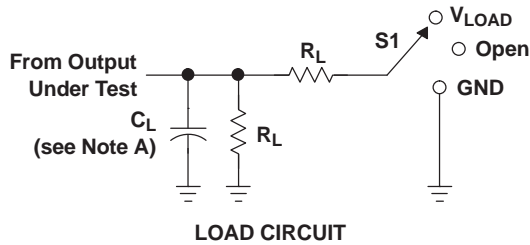
| PARAMETER | FROM (INPUT) | TO (OUTPUT) | V _{CC} = 2.7 V | | V _{CC} = 3.3 V ± 0.3 V | | UNIT |
|------------------|--------------|-------------|-------------------------|-----|---------------------------------|-----|------|
| | | | MIN | MAX | MIN | MAX | |
| f _{max} | | | 83 | | 100 | | MHz |
| t _{pd} | CLK | Q or Q̄ | 6 | | 1 | 5.2 | ns |
| | PRE or CLR | | 6.4 | | 1 | 5.4 | |

Operating Characteristics

T_A = 25°C

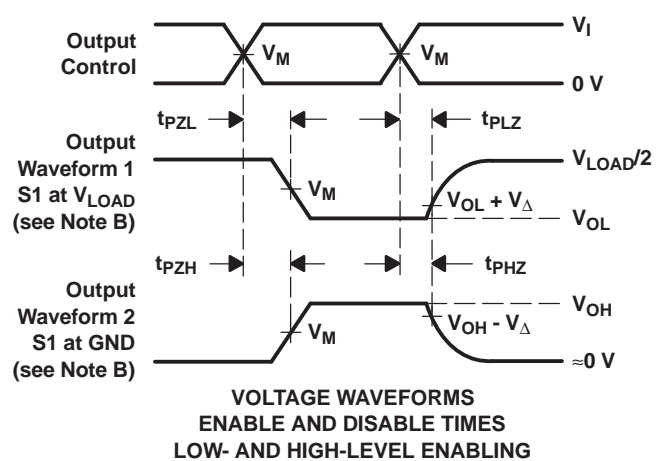
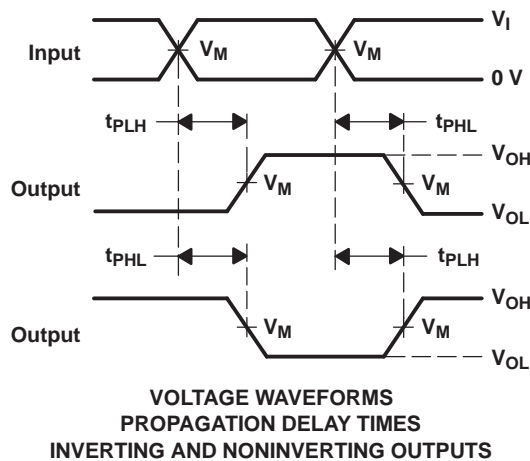
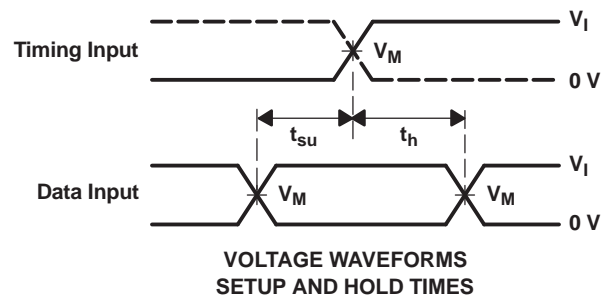
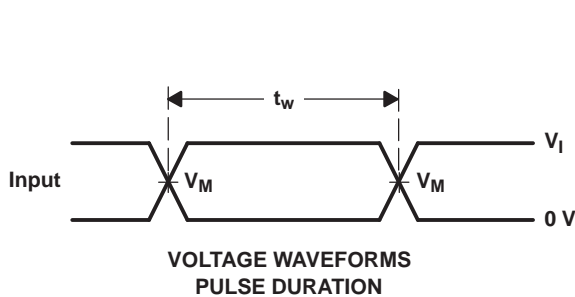
| PARAMETER | TEST CONDITIONS | V _{CC} = 2.5 V | V _{CC} = 3.3 V | UNIT |
|-----------------|-----------------|-------------------------|-------------------------|------|
| | | TYP | TYP | |
| C _{pd} | f = 10 MHz | 47 | 51 | pF |

PARAMETER MEASUREMENT INFORMATION



| TEST | S1 |
|-------------------|------------|
| t_{PLH}/t_{PHL} | Open |
| t_{PLZ}/t_{PZL} | V_{LOAD} |
| t_{PHZ}/t_{PZH} | GND |

| V_{CC} | INPUTS | | V_M | V_{LOAD} | C_L | R_L | V_{Δ} |
|-------------------|--------|---------------|-------|------------|-------|--------------|--------------|
| | V_I | t_r/t_f | | | | | |
| 2.7 V | 2.7 V | ≤ 2.5 ns | 1.5 V | 6 V | 50 pF | 500 Ω | 0.3 V |
| 3.3 V \pm 0.3 V | 2.7 V | ≤ 2.5 ns | 1.5 V | 6 V | 50 pF | 500 Ω | 0.3 V |



- NOTES:
- A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \Omega$.
 - D. The outputs are measured one at a time, with one transition per measurement.
 - E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - F. t_{PZL} and t_{PZH} are the same as t_{en} .
 - G. t_{PLH} and t_{PHL} are the same as t_{pd} .
 - H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms

PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead finish/ Ball material (6) | MSL Peak Temp (3) | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|---------------|--------------|-----------------|------|-------------|-----------------|--------------------------------------|----------------------|--------------|-------------------------|-------------------------|
| SN74LVC74AMDREP | ACTIVE | SOIC | D | 14 | 2500 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -55 to 125 | LVC74AM | Samples |
| SN74LVC74AMPWREP | ACTIVE | TSSOP | PW | 14 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -55 to 125 | LVC74AM | Samples |
| SN74LVC74AQDREP | ACTIVE | SOIC | D | 14 | 2500 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | LVC74AE | Samples |
| SN74LVC74AQPWREP | ACTIVE | TSSOP | PW | 14 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | LVC74AE | Samples |
| V62/04669-01XE | ACTIVE | SOIC | D | 14 | 2500 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | LVC74AE | Samples |
| V62/04669-01YE | ACTIVE | TSSOP | PW | 14 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | LVC74AE | Samples |
| V62/04669-02XE | ACTIVE | SOIC | D | 14 | 2500 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -55 to 125 | LVC74AM | Samples |
| V62/04669-02YE | ACTIVE | TSSOP | PW | 14 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -55 to 125 | LVC74AM | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF SN74LVC74A-EP :

- Catalog: [SN74LVC74A](#)
- Automotive: [SN74LVC74A-Q1](#)
- Military: [SN54LVC74A](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Military - QML certified for Military and Defense Applications

TAPE AND REEL INFORMATION

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|------------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| SN74LVC74AMDREP | SOIC | D | 14 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |
| SN74LVC74AMPWREP | TSSOP | PW | 14 | 2000 | 330.0 | 12.4 | 6.9 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |
| SN74LVC74AQDREP | SOIC | D | 14 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |
| SN74LVC74AQPWREP | TSSOP | PW | 14 | 2000 | 330.0 | 12.4 | 6.9 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| SN74LVC74AMDREP | SOIC | D | 14 | 2500 | 333.2 | 345.9 | 28.6 |
| SN74LVC74AMPWREP | TSSOP | PW | 14 | 2000 | 356.0 | 356.0 | 35.0 |
| SN74LVC74AQDREP | SOIC | D | 14 | 2500 | 340.5 | 336.1 | 32.0 |
| SN74LVC74AQPWREP | TSSOP | PW | 14 | 2000 | 356.0 | 356.0 | 35.0 |

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - $\triangle C$ Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
 - $\triangle D$ Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
 - E. Reference JEDEC MS-012 variation AB.

PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



4040064-3/G 02/11

- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
 - D. Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
 - E. Falls within JEDEC MO-153

PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



4211284-2/G 08/15

- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Publication IPC-7351 is recommended for alternate designs.
 - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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